



## New high-resolution optical 3D surface metrology methods for bullet and cartridge case identification

AFTE 2017 - 17<sup>th</sup> May 2017  
Denver

# SUMMARY

- ▶ Motivation
- ▶ Traditional and New 3D methods
  1. Bullets
  2. Cartridge cases
- ▶ Conclusions

# MOTIVATION

Surface metrology experts



- + 15 years
- + 600 systems worldwide

# MOTIVATION

Surface metrology experts + Firearms & tool marks community



NIST



- Objective Identification (AFTE 2016)
- Optimize 3D measurements (AFTE 2017)

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# TRADITIONAL 3D METHODS



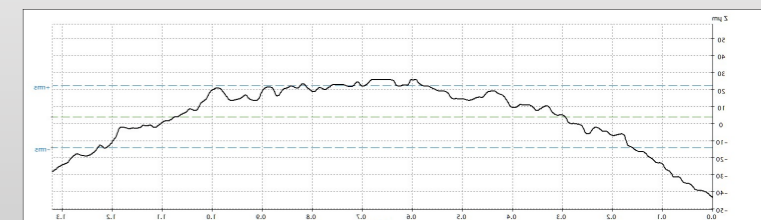
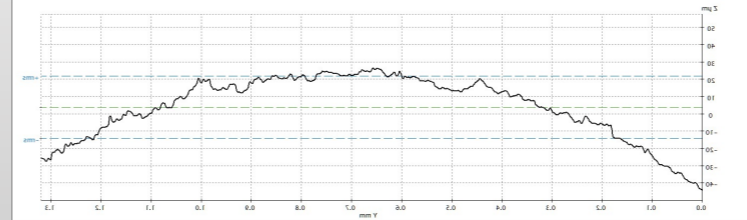
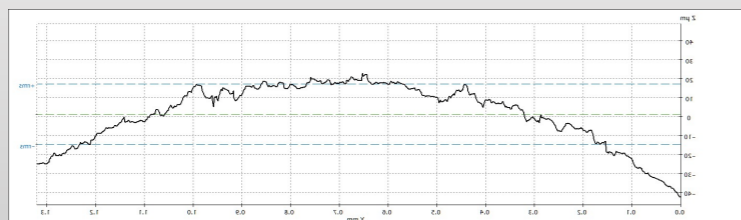
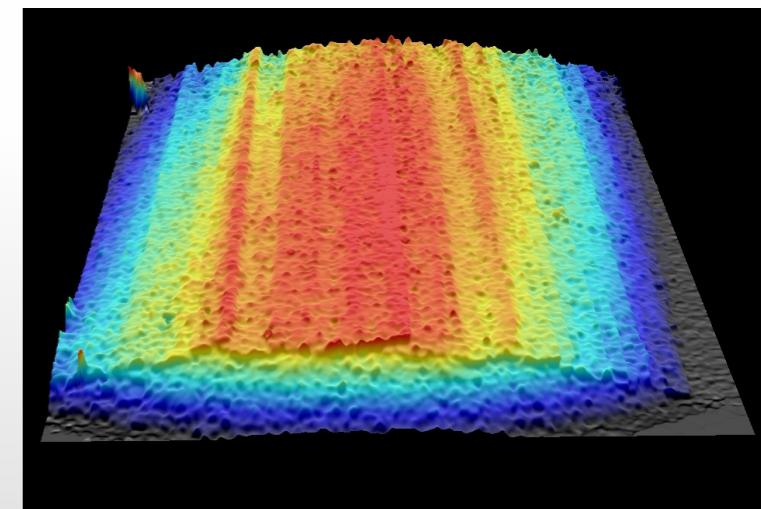
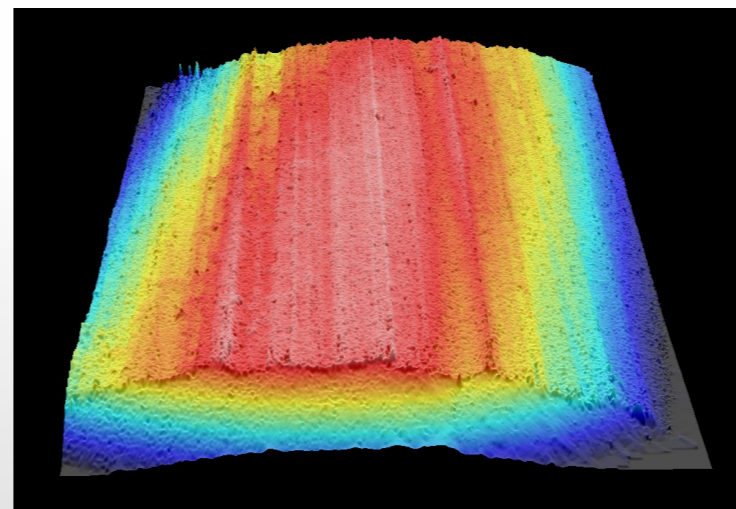
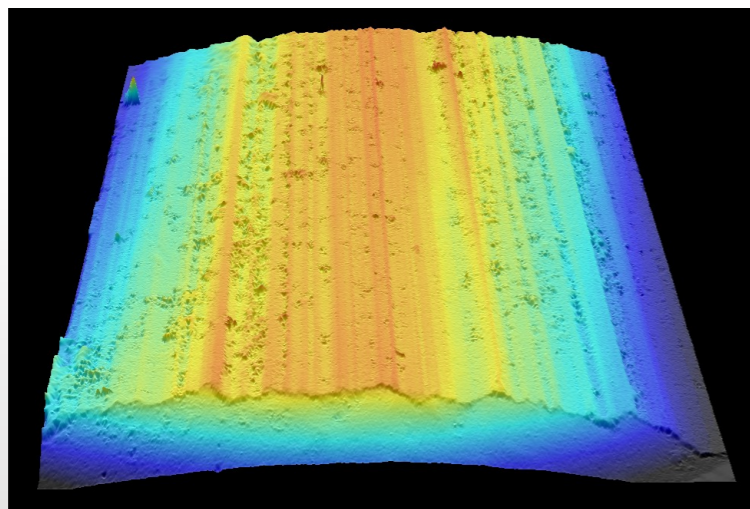
CSI  
Interferometry



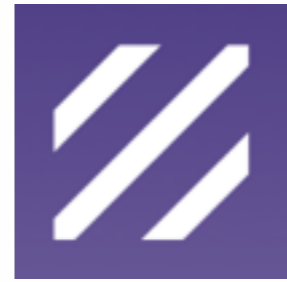
Confocal



Focus Variation



# TRADITIONAL 3D METHODS



CSI  
Interferometry



Confocal



Focus Variation

Rough samples



Smooth samples



Micro-scale features (XY/Z)



Nano-scale features (Z)



High local slopes (>20°)



Speed



# TRADITIONAL 3D METHODS



CSI  
Interferometry



Confocal



Focus Variation

Rough samples



Smooth samples



Micro-scale features (XY/Z)



Nano-scale features (Z)



High local slopes vs NA







Speed





# NEW 3D METHODS

		<b>NEW</b> 	<b>NEW</b> 	
	CSI Interferometry	<b>Continuous Confocal</b>	<b>Confocal Fusion</b>	Focus Variation
Rough samples	★	★★	★★★	★★★
Smooth samples	★★★	★★★	★★★	—
Micro-scale features (XY/Z)	★★★	★★★	★★★	★★
Nano-scale features (Z)	★★★	★★	★★★	—
High local slopes (>20°)	★	★★	★★★	★★★
Speed	★	3x faster ★★★	★★★	★★★

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# NEW 3D METHODS / BULLETS

NIST SRM 2460

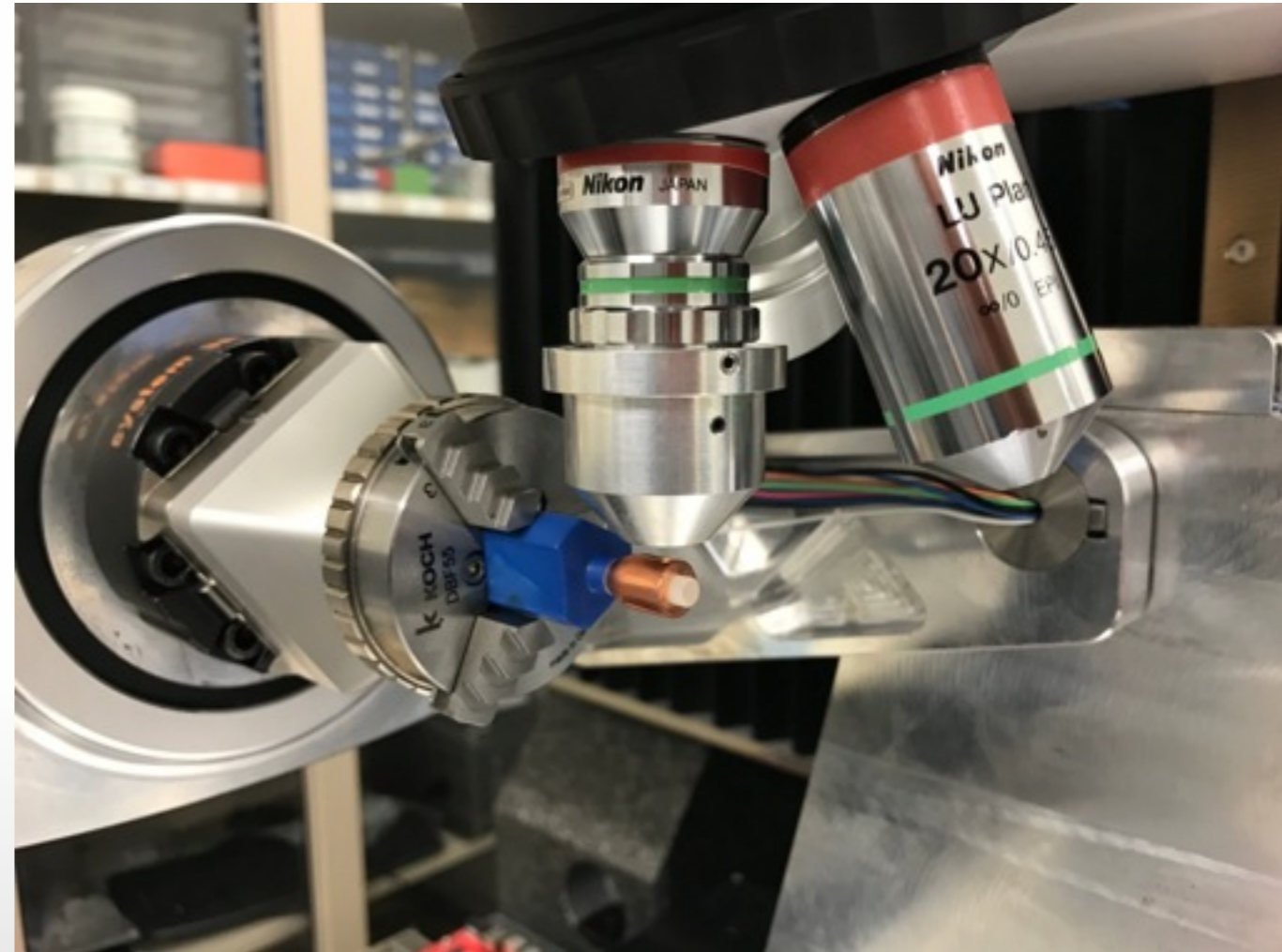
Four 3D methods:

- CSI
- Confocal (C)
- Continuous Confocal (CC)
- Focus Variation (FV)

20X objective:

- NA 0.45 (EPI) & 0.4 (DI)
- Pixel size 0.65 micrometers

Z scan range 190 micrometers



# NEW 3D METHODS / BULLETS

Sensofar's objective identification methodology (AFTE 2016)

- IC surface extraction for each technique
- IC created from NIST SRM 2460 virtual profiles (contact stylus profiler)



1. Land surface measurements
2. IC extraction



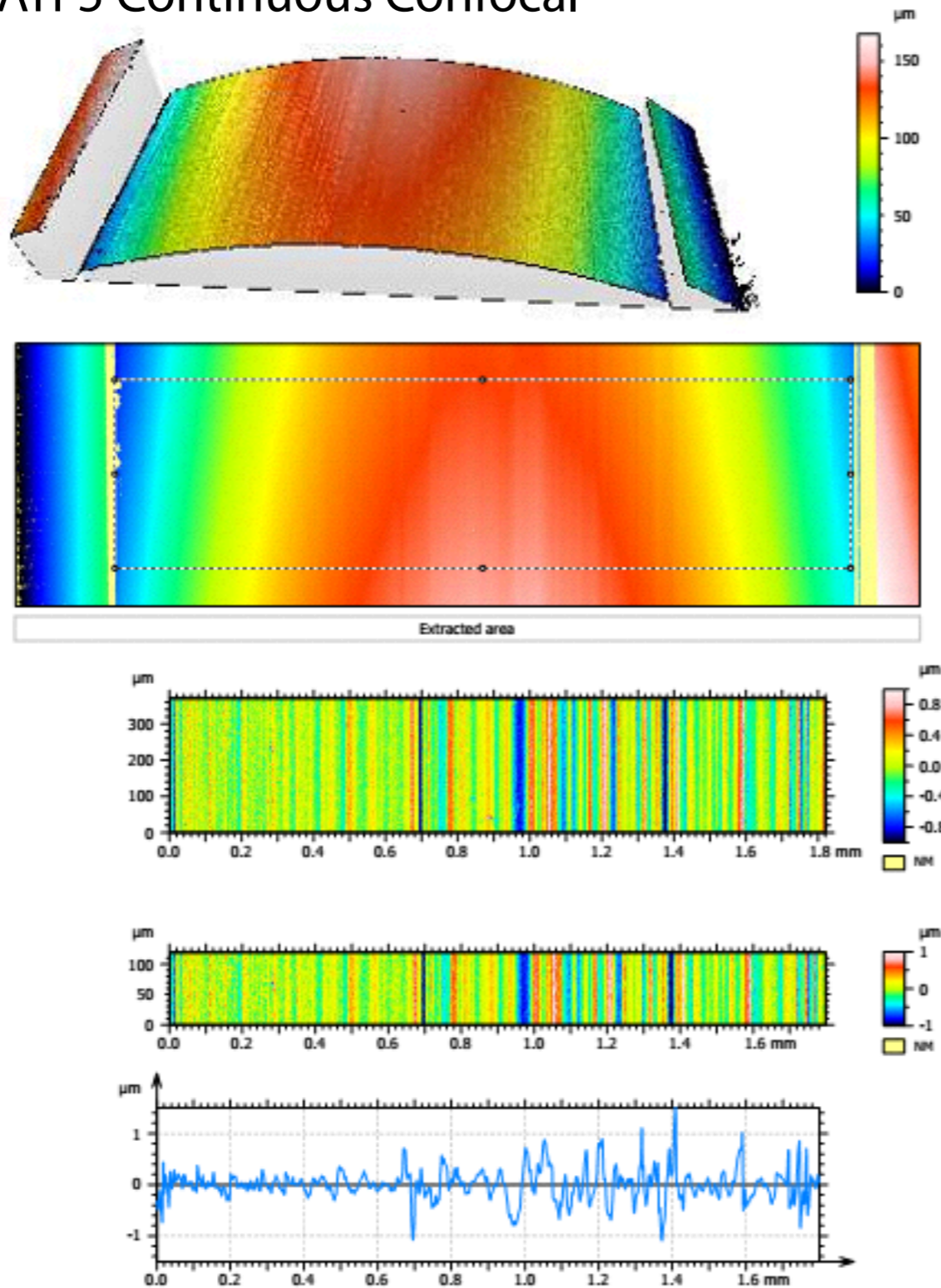
3. IC comparison ( $CCF_{max}$ )
4. Bullet comparisons:  
new automated  
comparison score:  
**Sequence Average  
Maximum (SAM)**



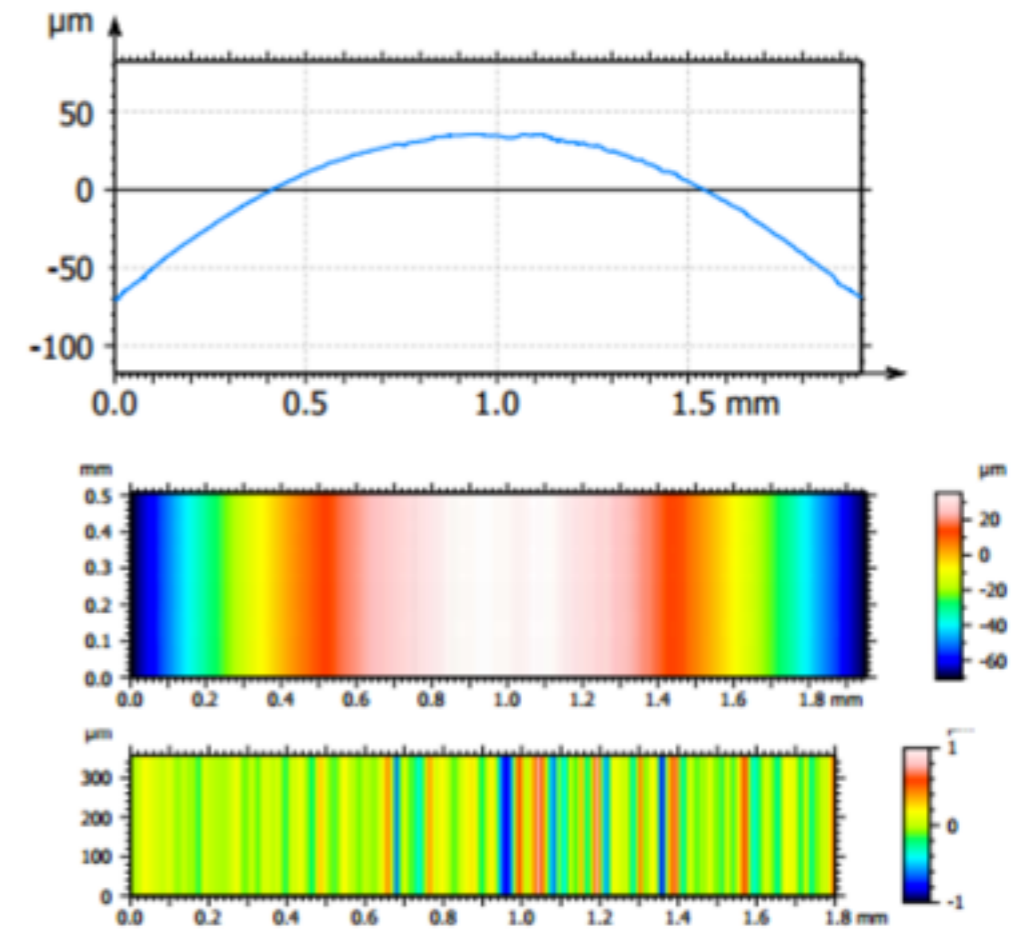
5. Top N list analysis

# NEW 3D METHODS / BULLETS

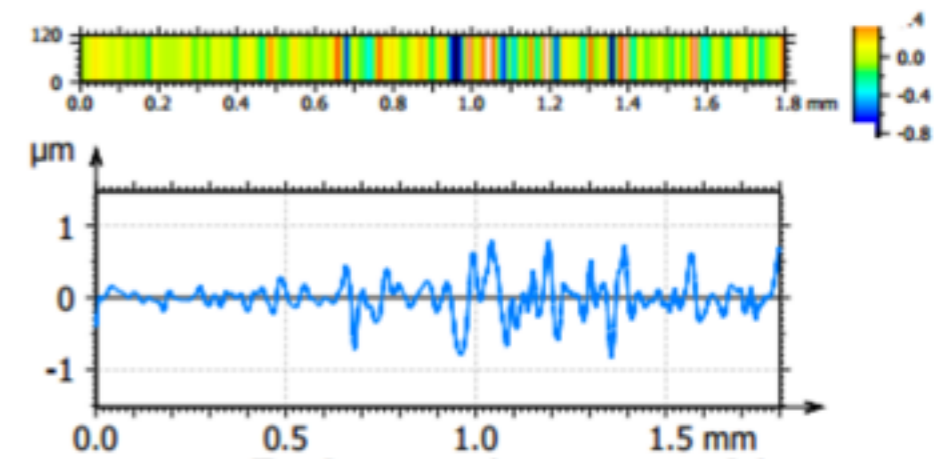
## ATF5 Continuous Confocal



## ATF5 Virtual Profile



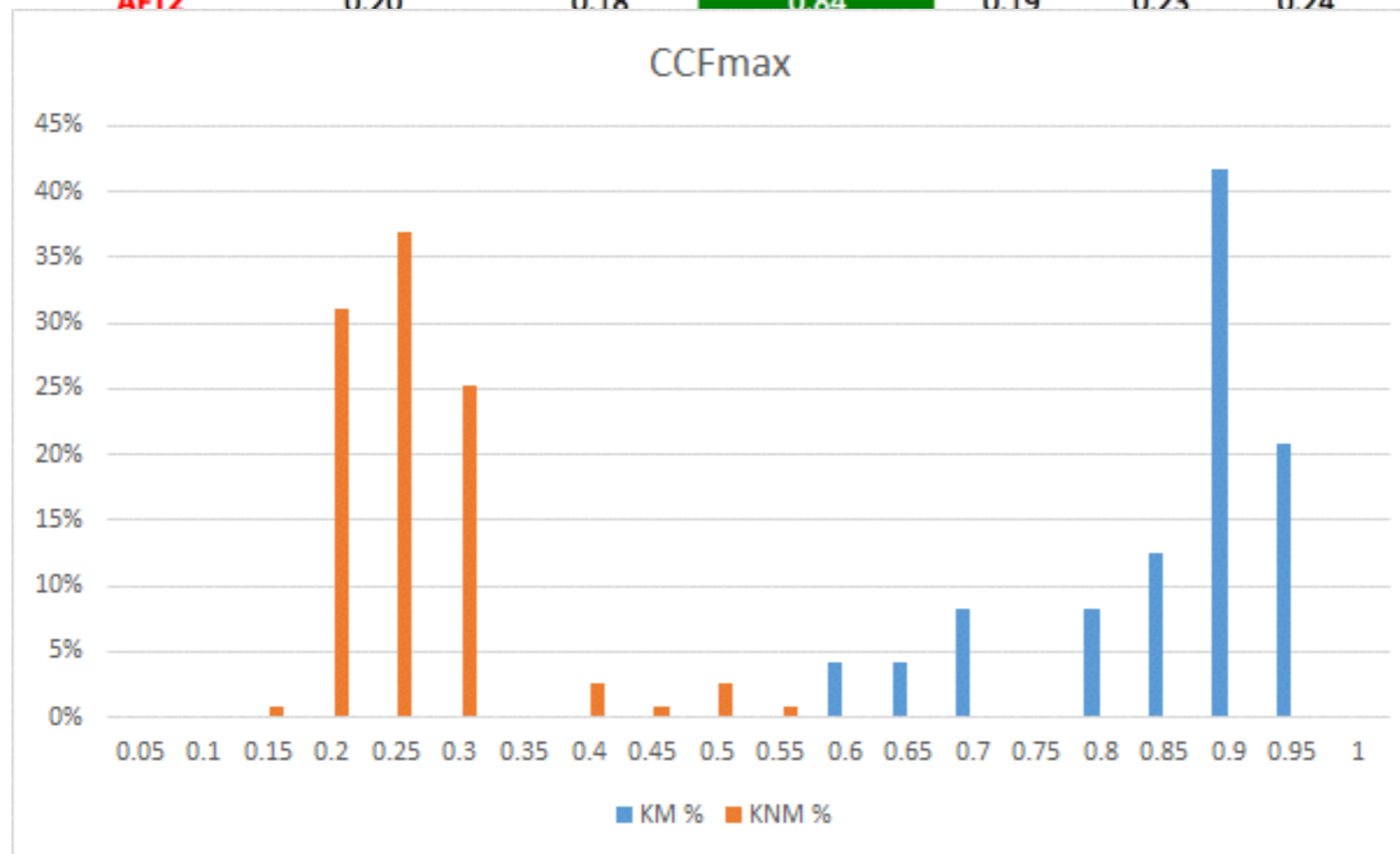
## NIST SRM2460 AFT5 IC surface



# NEW 3D METHODS / BULLETS

Comparison of KM  $CCF_{max}$  for different techniques for all NIST SRM 2460 LEA

	CSI	AFT5	AFT4	AFT2	FBI3	FBI2	FBI1
AFT5		0.91	0.19	0.23	0.18	0.25	0.25
AFT4		0.18	0.87	0.17	0.17	0.14	0.20
AFT2		0.20	0.18	0.84	0.19	0.23	0.24



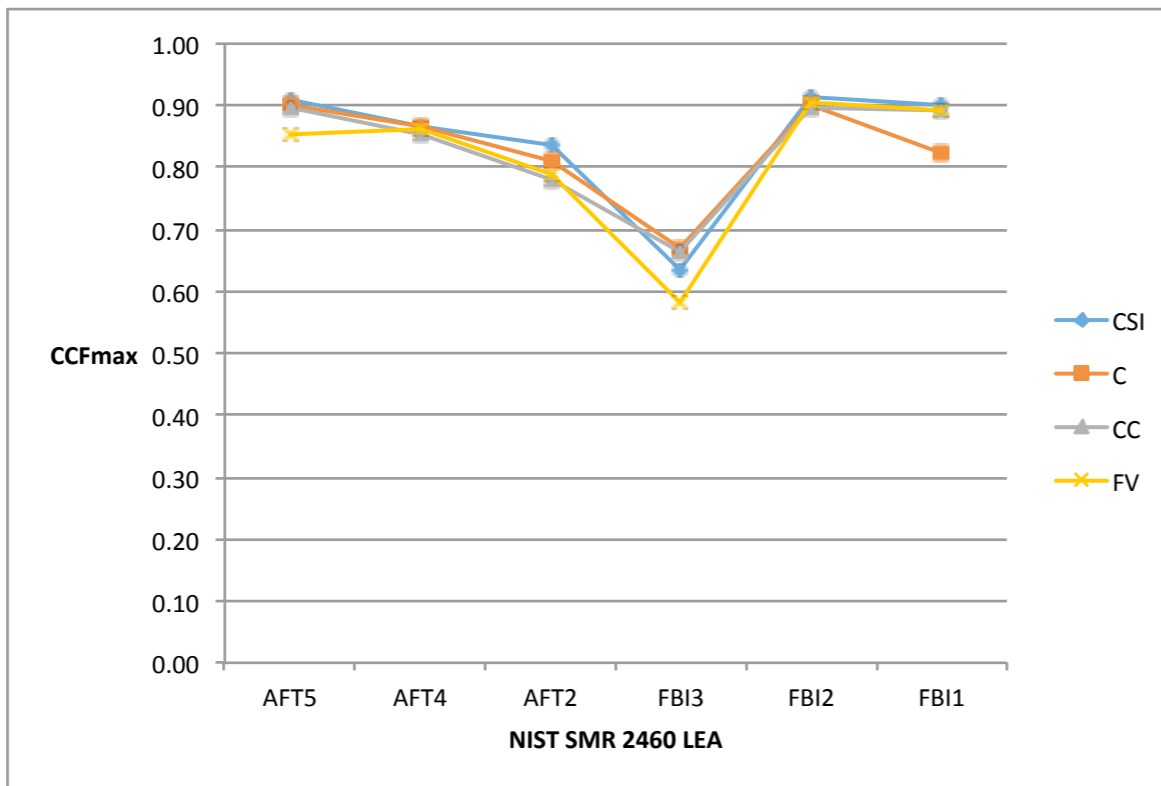
KM  $CCF_{max}$   
average = 0.83

KNM  $CCF_{max}$   
average = 0.24

AFT5	0.85	0.23	0.25	0.25	0.28	0.27
AFT4	0.19	0.86	0.22	0.20	0.18	0.24
AFT2	0.22	0.21	0.79	0.18	0.25	0.26
FBI3	0.17	0.19	0.20	0.58	0.24	0.22
FBI2	0.29	0.22	0.30	0.26	0.91	0.49
FBI1	0.22	0.25	0.26	0.19	0.39	0.89

# NEW 3D METHODS / BULLETS

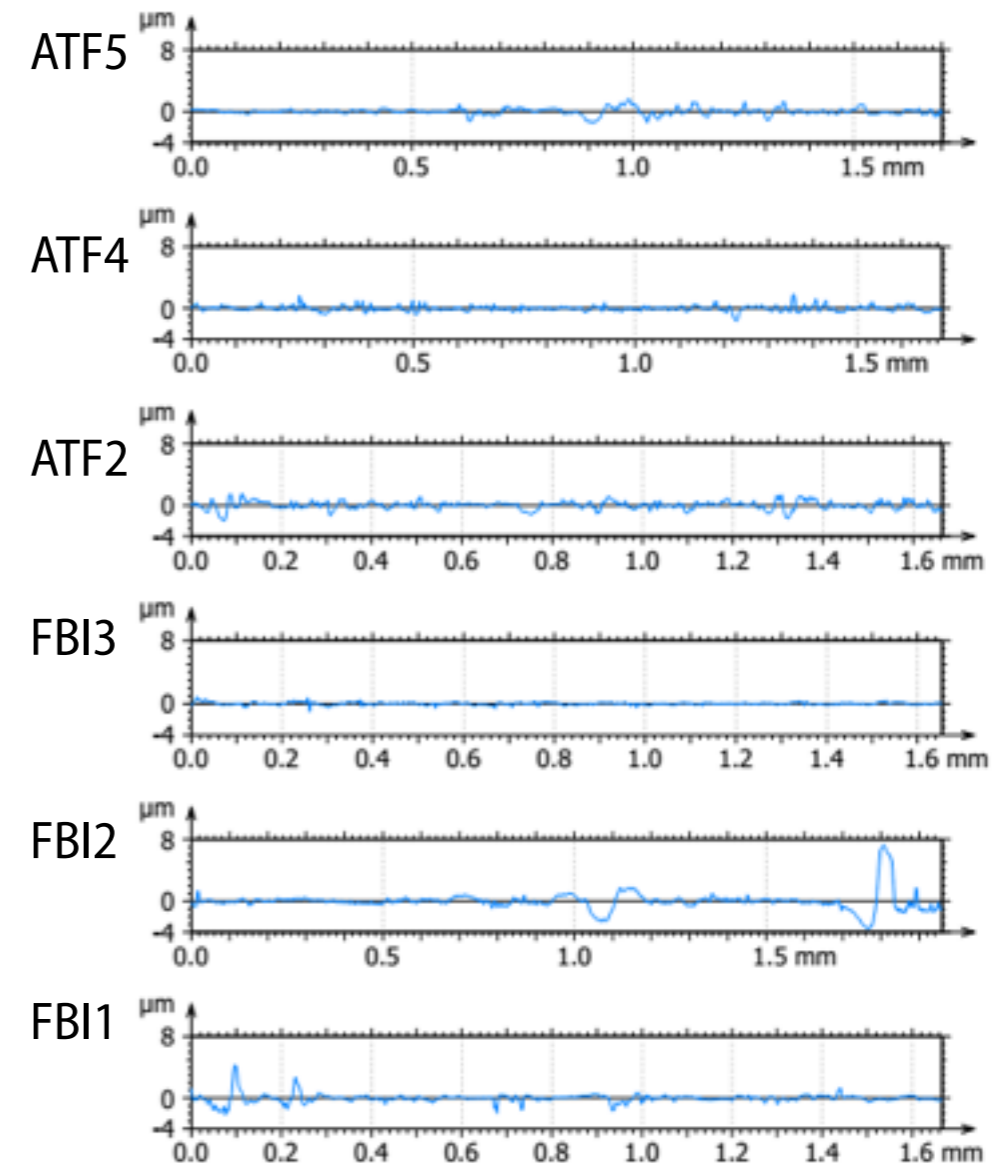
Comparison of KM  $CCF_{max}$  for different techniques for all NIST SRM 2460 LEA



Good agreement

Better Z resolution = higher  $CCF_{max}$

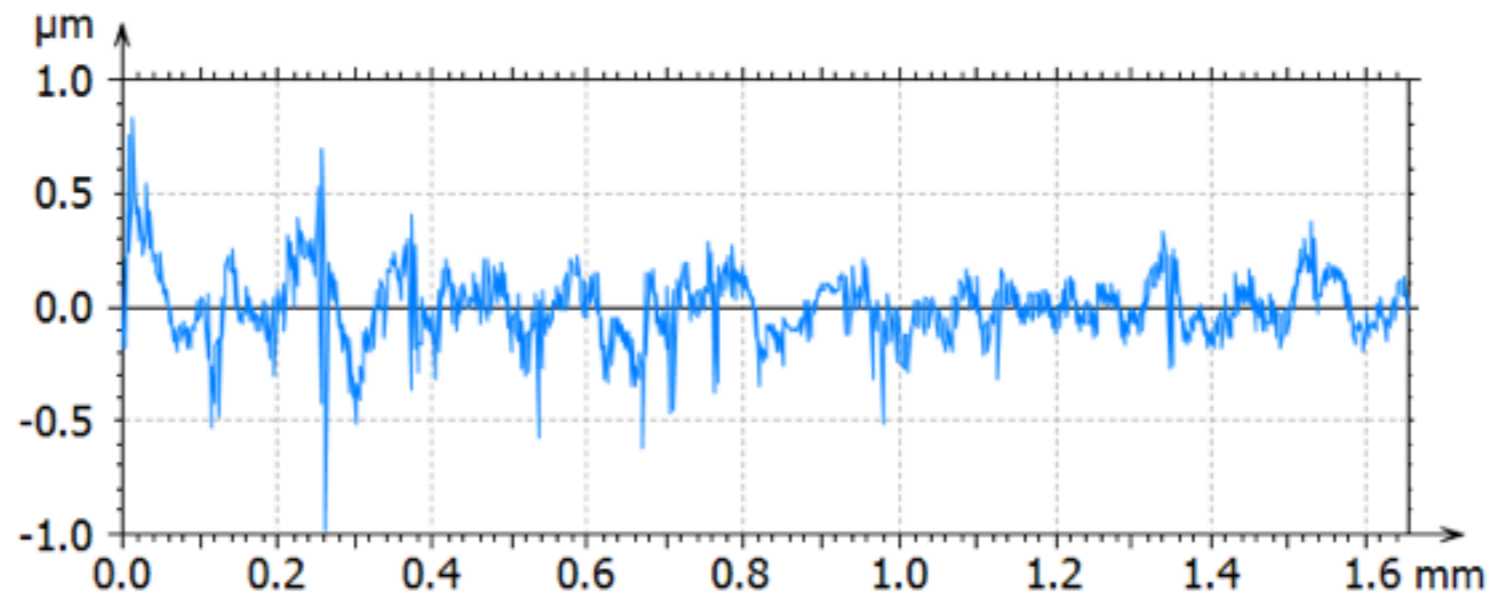
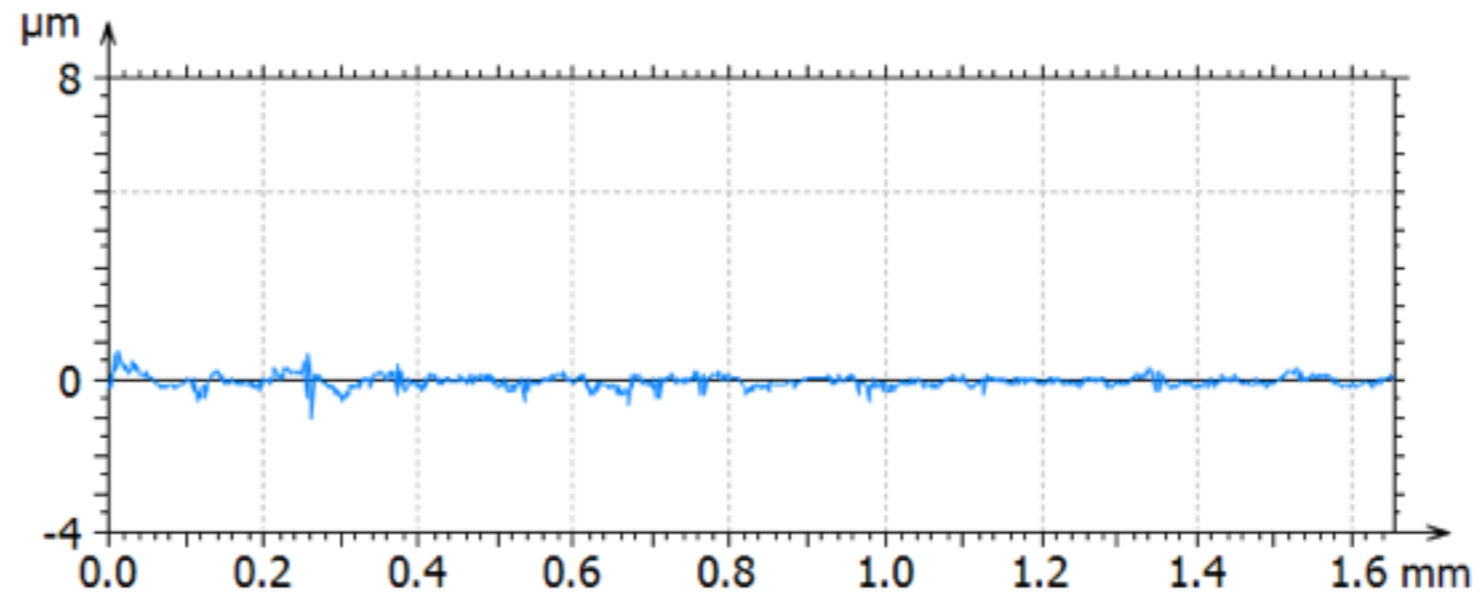
Weakest mark has lower  $CCF_{max}$



# NEW 3D METHODS / BULLETS

Z resolution

FBI3

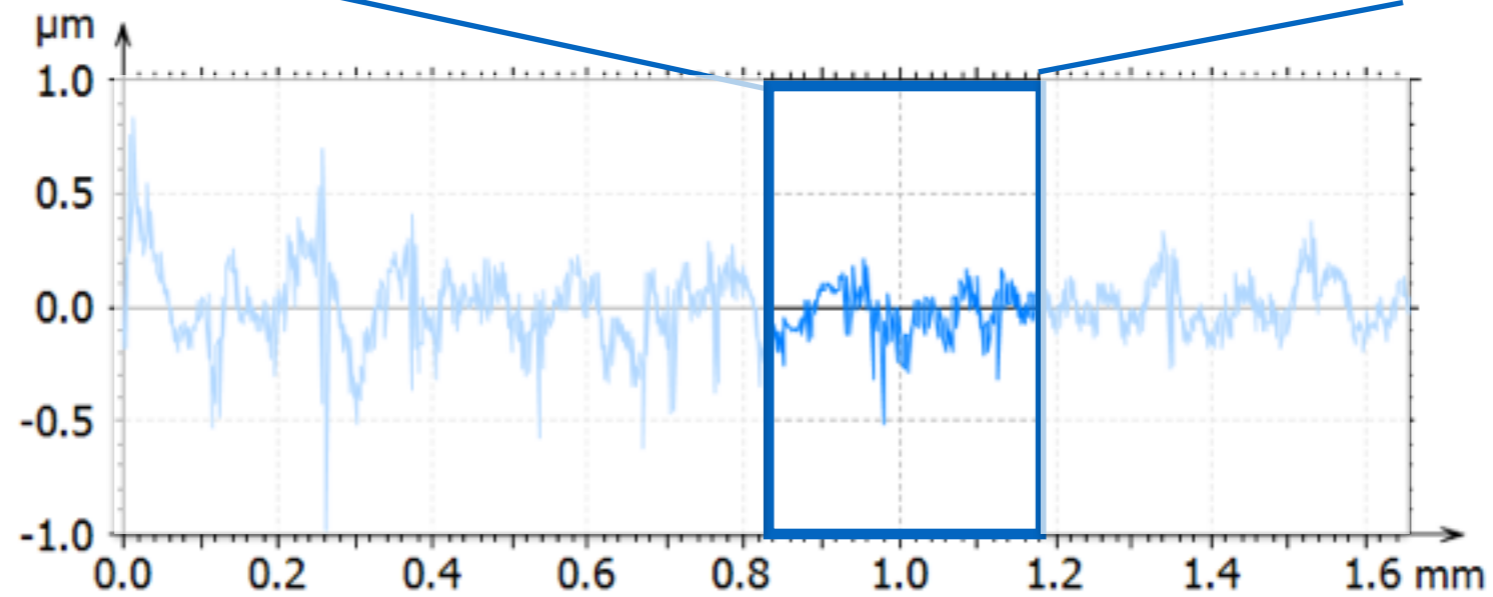
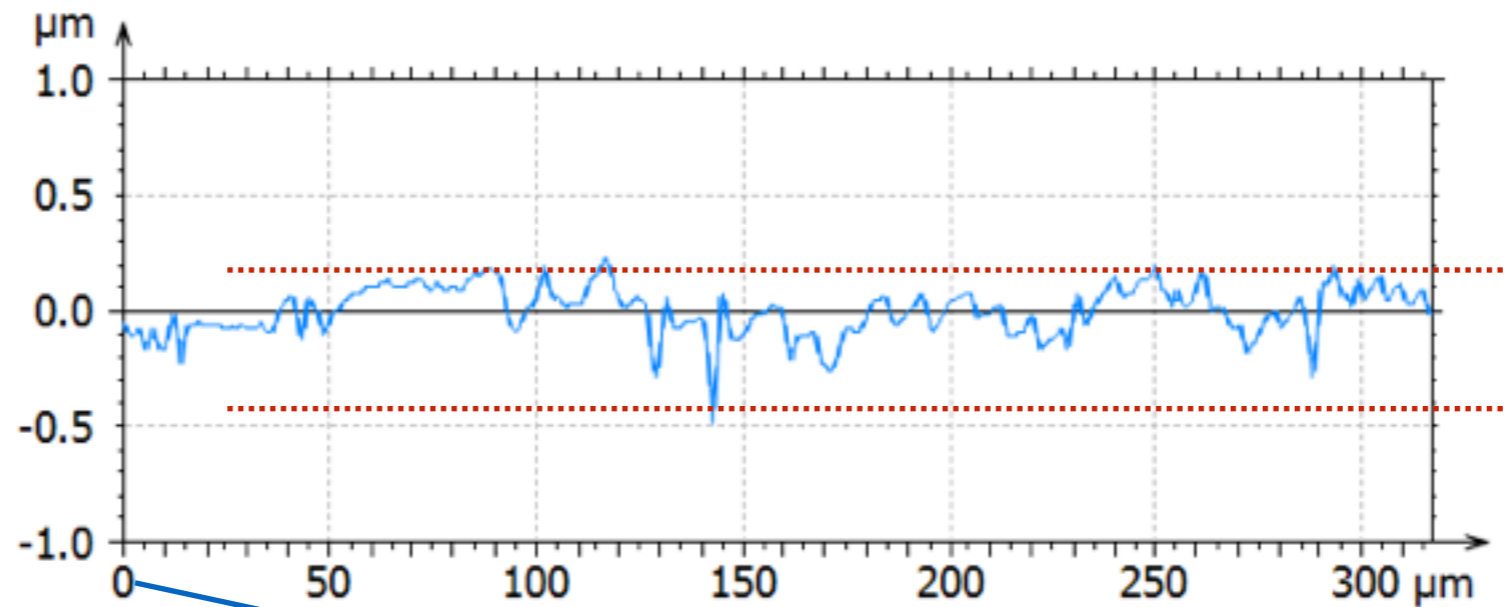




# NEW 3D METHODS / BULLETS

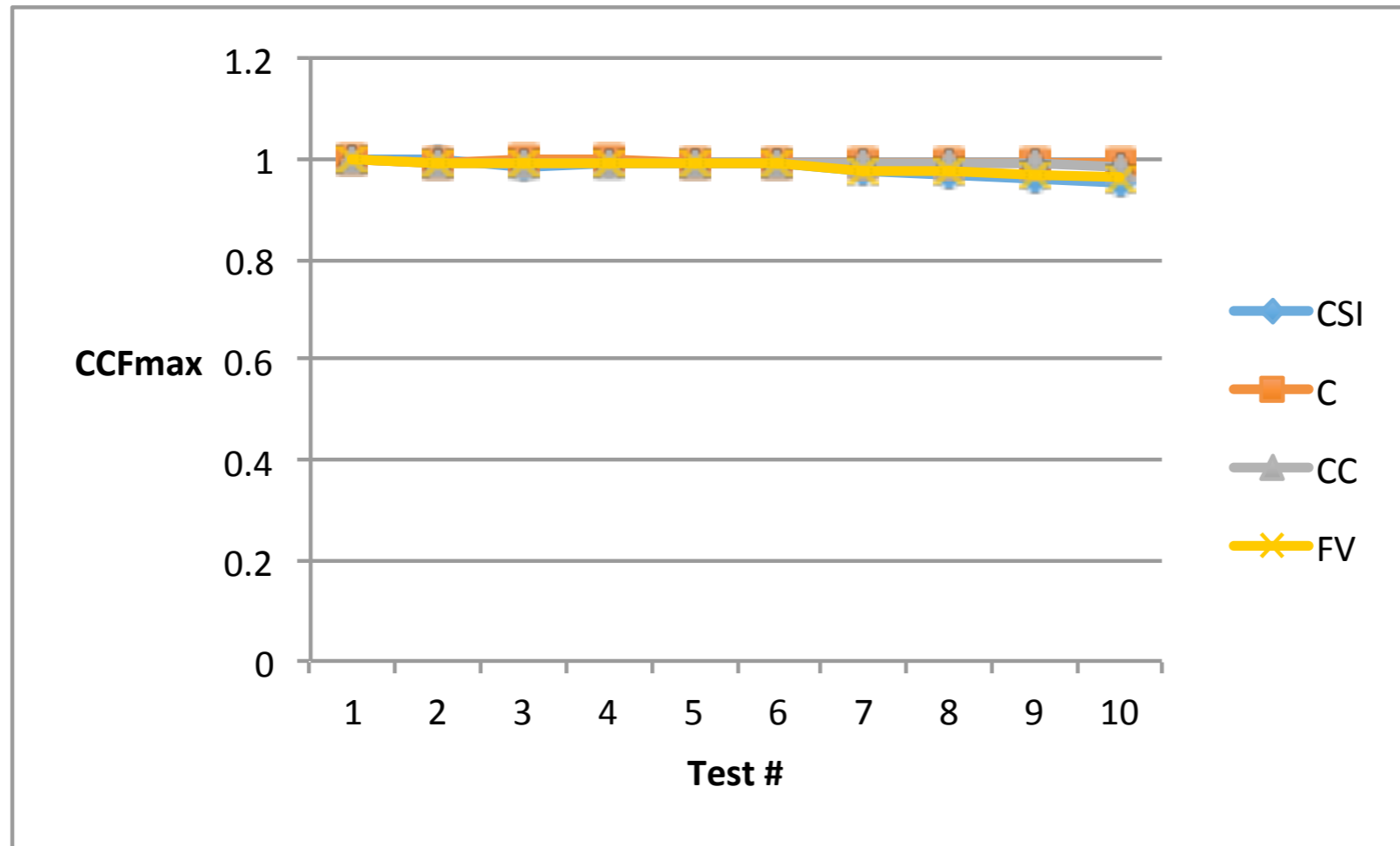
Z resolution

FBI3



# NEW 3D METHODS / BULLETS

Repeatability test on NIST SRM 2460 LEA ATF5



FV: 47 s

**CC: 50 s**

C: 3 m 40 s x4

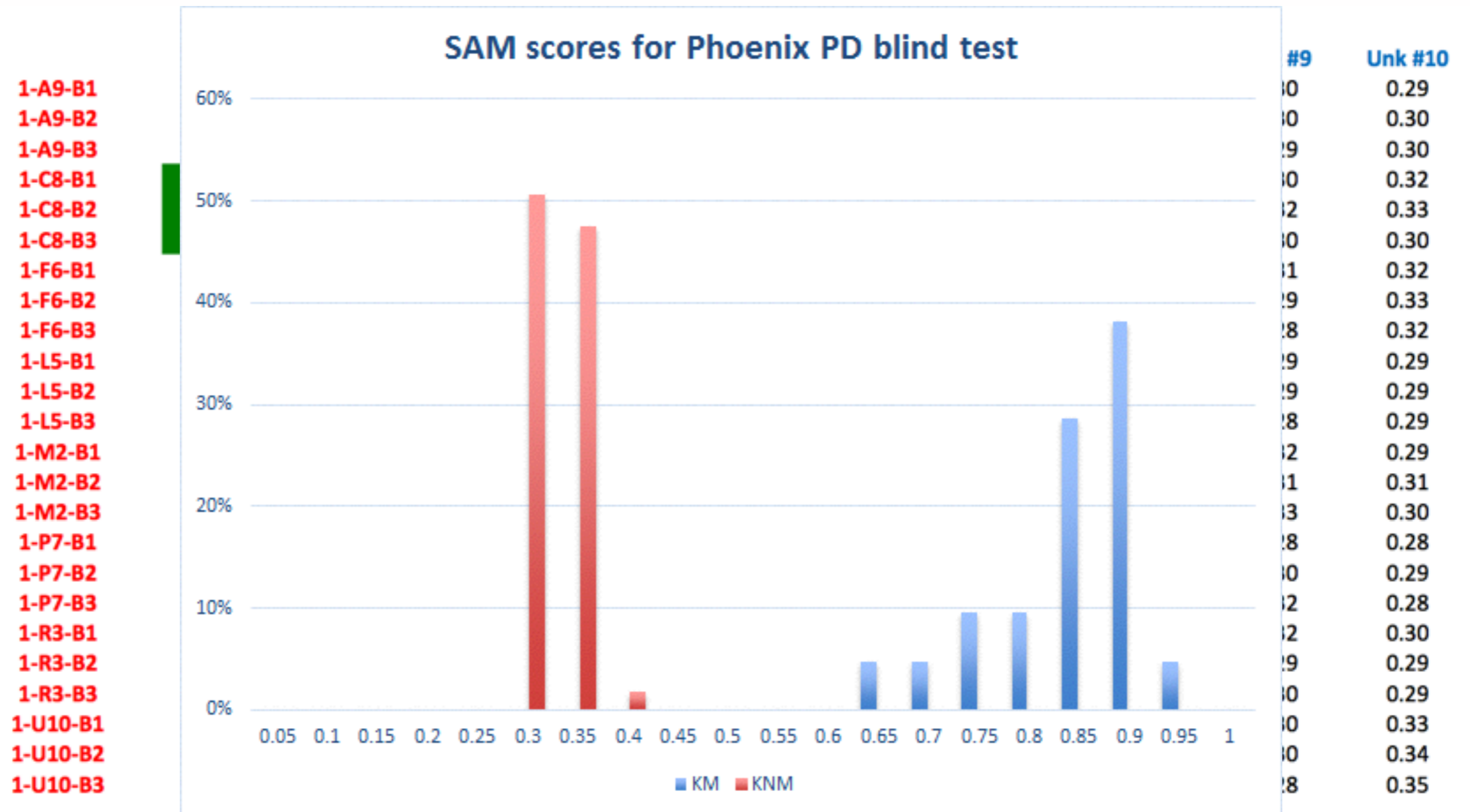
CSI: 9m 54 s x10

	CSI	C	<b>CC</b>	FV
Average	0.982	0.993	0.991	0.986
std	0.011	0.001	0.003	0.009
std %	1.15%	0.13%	0.29%	0.92%

# NEW 3D METHODS / BULLETS

Phoenix PD blind test **successfully** solved using S neox, Continuous Confocal, 20X & SAM score

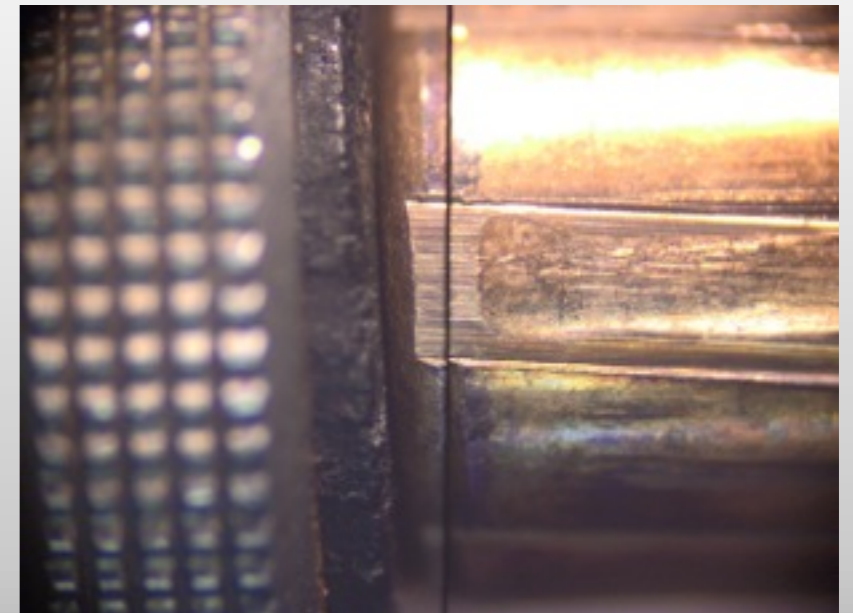
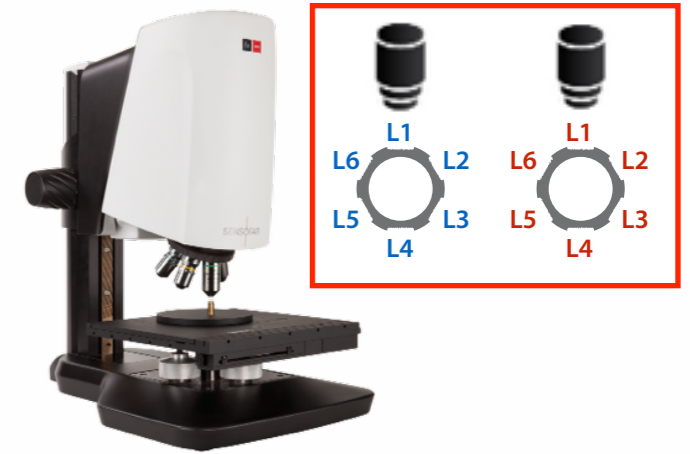
- 8 guns (3 test fires)
- 10 unknowns



# NEW 3D METHODS / BULLETS

A subset of this study solved by 3 examiners at Guardia Civil (Barcelona) using Virtual Microscopy SensoCOMP

- 3 Ruger guns (3 test fires)
- 2 unknowns



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# NEW 3D METHODS / CARTRIDGES

Three Glock S&W 40

Two 3D measurement methods:

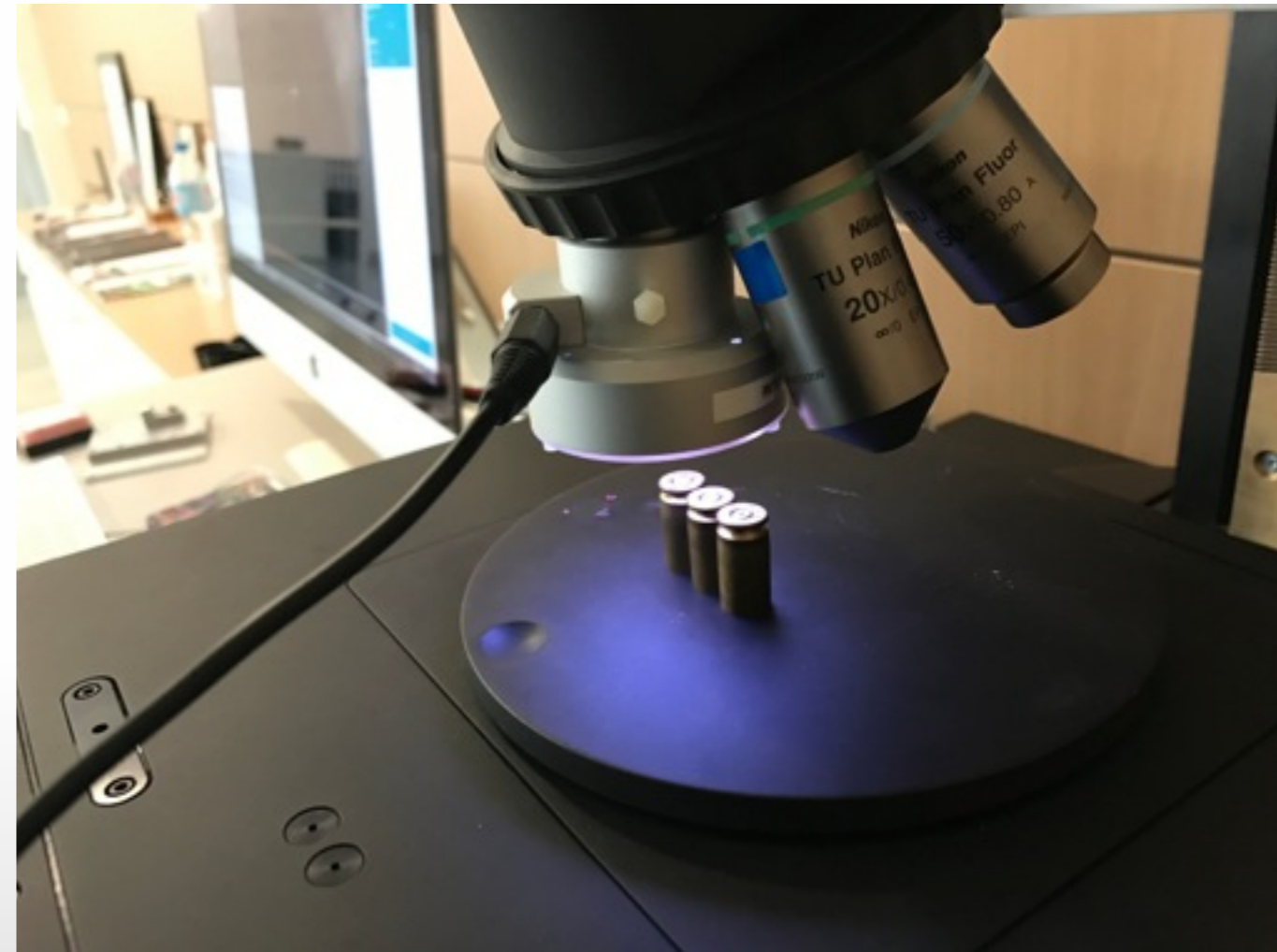
- Continuous Confocal (CC)
- Focus Variation (FV)

10X objective:

- NA 0.3
- 1.3 micrometers pixel

Z scan range 600 micrometers  
(firing ping included)

Virtual Microscopy comparison



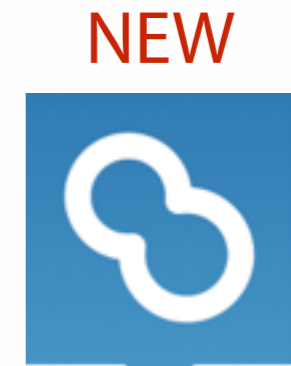
# NEW 3D METHODS / CARTRIDGES



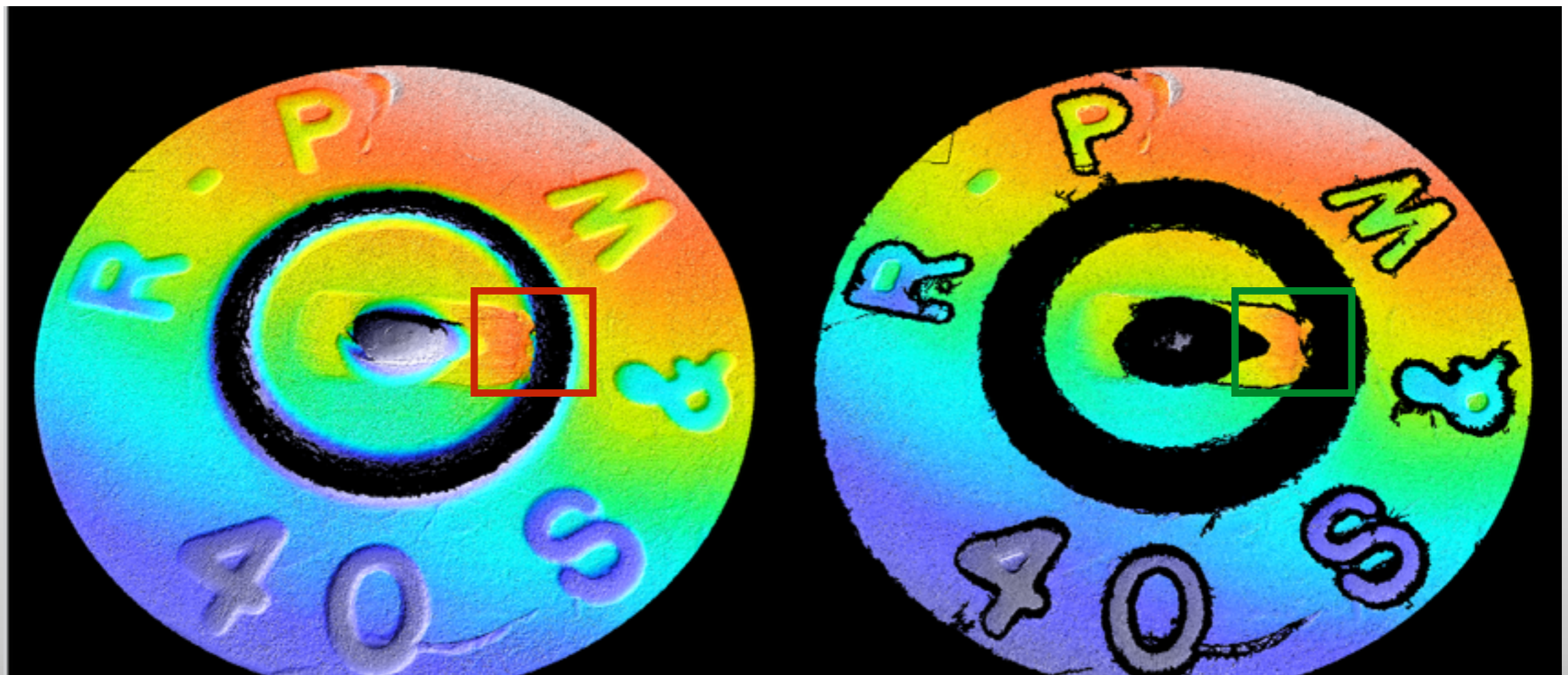
Focus Variation



full < 10 m  
breach face < 2 m

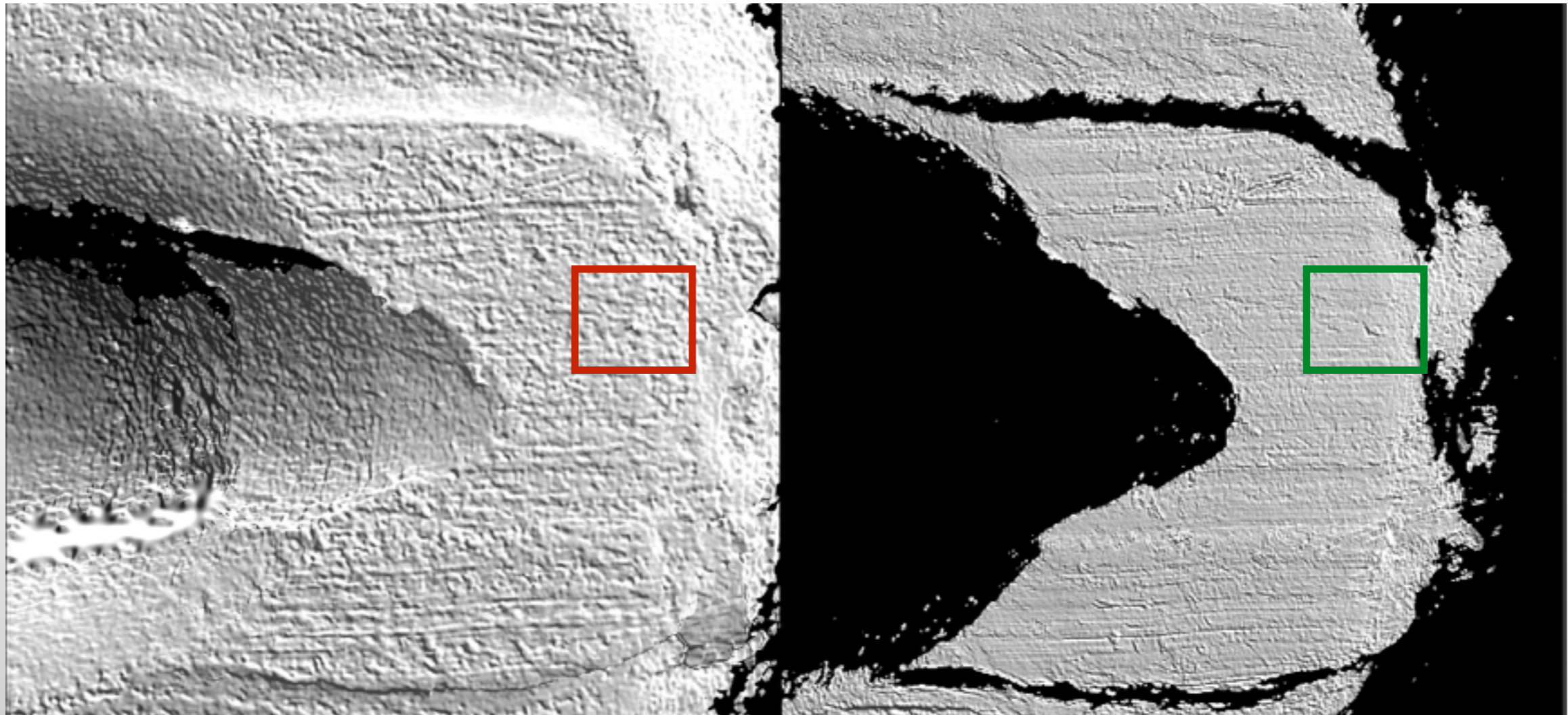


Continuous  
Confocal



# NEW 3D METHODS / CARTRIDGES

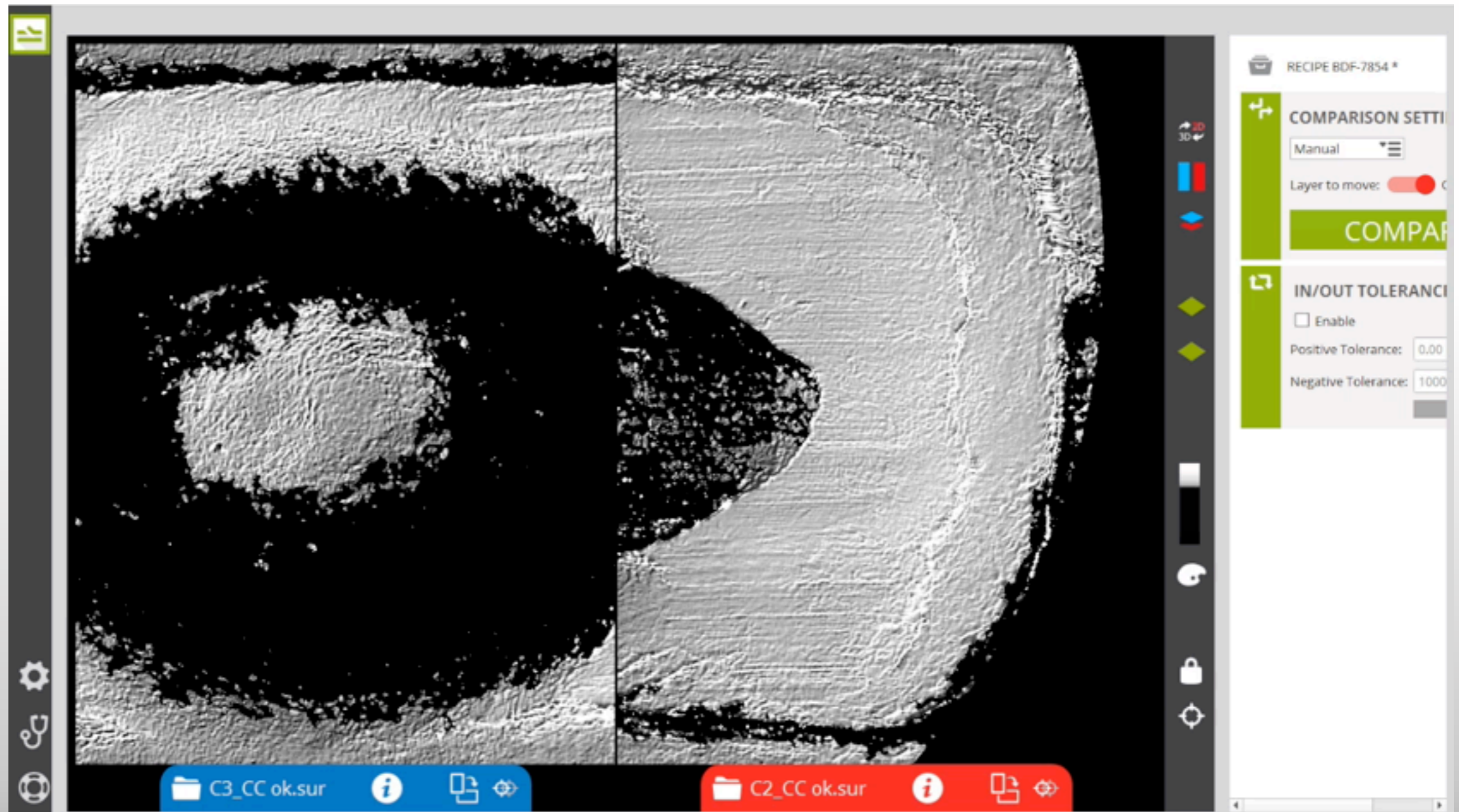
Visual comparison of **Focus Variation** vs **Continuous Confocal** on the aperture shear





# NEW 3D METHODS / CARTRIDGES

Visual comparison of two different cartridges fired with same firearm  
*SensoCOMP Virtual Microscopy (VM) software tool*



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# CONCLUSIONS

1. Two new high-resolution optical 3D surface metrology methods have been presented and compared to existing methods using Sensofar S neox system
2. **Continuous Confocal** offers the **best performance at 3x speed**

Validation tests using  $CCF_{max}$ , SAM and VM

- NIST SRM 2460 bullet
- Phoenix PD blind test bullets
- Glock S&W 40 cartridge cases

3. **Confocal Fusion** shows promise for **cartridge case** 3D measurements

## Acknowledgments

- Roger Artigas & Pol Martinez @ Sensofar
- Erich Smith @ FBI
- Antonio Garrido, Miguel Ángel and Sara @ Guardia Civil
- Tylor Klep @ Phoenix PD

## Announcements

- Examiners are invited to test these new techniques at Iowa State University
- Examiners are invited to solve the Phoenix PD study using Virtual Microscopy

# Thank you for your attention!

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